Ammonium Hydroxide 29% CMOS





Material No.: 9731-03 Batch No.: 0000003006 Manufactured Date: 2012/04/25

Certificate of Analysis

Test	S pecification	Result
Appearance	Passes Test	РТ
Assay (as NH₃)	28.0 - 30.0 %	28.7
Color (APHA)	<=7	< 5
Insoluble Matter	<= 1 ppm	<1
Residue after Ignition	<= 3 ppm	<3
Carbon Dioxide (CO2)	<=10 ppm	<10
Pyridine	Passes Test	РТ
Substances Reducing Permanganate	Passes Test	РТ
Chloride (Cl)	<=0.3 ppm	< 0.2
Phosphate (PO4)	<=0.2 ppm	< 0.2
Total Sulfur (as SO4)	<=0.8 ppm	< 0.2
Trace Impurities – Aluminum (Al)	<=10.0 ppb	< 5.0
Trace Impurities –Arsenic (As)	<= 50.0 ppb	<2.0
Arsenic and Antimony (as As)	<= 30 ppb	< 5
Trace Impurities –Barium (Ba)	<=10.0 ppb	<1.0
Trace Impurities –Beryllium (Be)	<= 10.0 ppb	<1.0
Trace Impurities – Bismuth (Bi)	<= 20.0 ppb	< 10.0
Trace Impurities –Boron (B)	<=10.0 ppb	< 5.0
Trace Impurities –Cadmium (Cd)	<= 5.0 ppb	<1.0
Trace Impurities -Calcium (Ca)	<=100.0 ppb	7.0
Trace Impurities – Chromium (Cr)	<= 5.0 ppb	<1.0
Trace Impurities -Cobalt (Co)	<=1.0 ppb	<1.0
Trace Impurities -Copper (Cu)	<=10.0 ppb	<1.0
Trace Impurities -Gallium (Ga)	<= 10.0 ppb	<1.0

For questions on this Certificate of Analysis please contact Technical Services at 855.282.6867 or +1.610.573.2600 Avantor ™ Performance Materials Inc.

3477 Corporate Parkway. Suite #200. Center Valley, PA 18034. U.S.A. Phone: 610.573.2600 . Fax: 610.573.2610

Test	S pecification	Result
Trace Impurities -Germanium (Ge)	<= 50.0 ppb	<10.0
Trace Impurities –Gold (Au)	<=10.0 ppb	< 5.0
Heavy Metals (as Pb)	<= 200 ppb	< 100
Trace Impurities –Iron (Fe)	<=10.0 ppb	1.0
Trace Impurities -Lead (Pb)	<=10.0 ppb	<10.0
Trace Impurities – Lithium (Li)	<=10.0 ppb	<1.0
Trace Impurities – Magnesium (Mg)	<= 50.0 ppb	1.0
Trace Impurities – Manganese (Mn)	<= 5.0 ppb	<1.0
Trace Impurities – Molybdenum (Mo)	<=10.0 ppb	< 5.0
Trace Impurities – Nickel (Ni)	<= 5.0 ppb	< 5.0
Trace Impurities – Niobium (Nb)	<=10.0 ppb	<1.0
Trace Impurities – Potassium (K)	<=100.0 ppb	<10.0
Trace Impurities – S ilicon (S i)	<=150.0 ppb	<10.0
Trace Impurities –Silver (Ag)	<= 5.0 ppb	<1.0
Trace Impurities – S odium (Na)	<=100.0 ppb	< 5.0
Trace Impurities – S trontium (S r)	<=10.0 ppb	<1.0
Trace Impurities – Tantalum (Ta)	<=10.0 ppb	< 5.0
Trace Impurities – Thallium (TI)	<=20.0 ppb	< 5.0
Trace Impurities – Tin (Sn)	<= 20.0 ppb	<10.0
Trace Impurities – Titanium (Ti)	<=10.0 ppb	<1.0
Trace Impurities – Vanadium (V)	<=10.0 ppb	<1.0
Trace Impurities –Zinc (Zn)	<= 5.0 ppb	<1.0
Trace Impurities – Zirconium (Zr)	<=10.0 ppb	<1.0
Particle Count –0.5 µm and greater	<= 80 par/ml	21
Particle Count - 1.0 µm and greater	<= 10 par/ml	7

For Microelectronic Use

Storage Conditions:

Country of Origin:	US
Packaging Site:	Paris Mfg Ctr & DC



Phillipsburg, NJ 9001.2008, 14001.2004 Paris, KY 9001.2008 Mexico city, Mexico 9001.2008 Deventer, The Netherlands 9001.2008, 14001.2004 Selangor, Malaysia 9001.2008 Panoli, India 9001.2008 Gliwice, Poland 9001.2008,17025.2005

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Richard M Siberski Global Director of Quality Assurance

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